

Notice of References Cited	Application/Control No. 10/568,114	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner ERIC R. HAMILL	Art Unit 2817	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0196119	10-2004	Shibahara et al.	333/193
*	B	US-5,592,135	01-1997	Taguchi et al.	333/193
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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